

Product Summary

$V_{(BR)DSS}$	$R_{DS(on)MAX}$	I_D
60V	8.5mΩ@10V	12A
	12mΩ@4.5V	

Feature

- Split Gate Trench MOSFET technology
- Excellent package for heat dissipation
- High density cell design for low RDS(ON)

Application

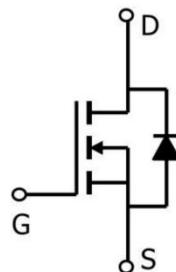
- DC-DC Converters
- Power management functions
- Industrial and Motor Drive application

Package



SOP-8

Circuit diagram



Marking



Absolute maximum ratings (T_A=25°C unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V _{DS}	60	V
Gate-Source Voltage	V _{GS}	±20	V
Continuous Drain Current	I _D	12	A
Continuous Drain Current(T _A =100°C)	I _D	7.5	A
Pulsed Drain Current ¹⁾	I _{DM}	48	A
Power Dissipation ³⁾	P _D	3.1	W
Thermal Resistance from Junction to Ambient ⁴⁾	R _{θJA}	40	°C/W
Avalanche energy ²⁾	E _{AS}	132	mJ
Junction Temperature	T _J	150	°C
Storage Temperature Range	T _{STG}	-55 ~ +150	°C

Electrical characteristics (T_J=25 °C, unless otherwise noted)

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Static Characteristics						
Drain-source breakdown voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D = 250μA	60			V
Zero gate voltage drain current	I _{DSS}	V _{DS} = 60V, V _{GS} = 0V			1	μA
Gate-body leakage current	I _{GSS}	V _{GS} = ±20V, V _{DS} = 0V			±100	nA
Gate threshold voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250μA	1.2	1.7	2.5	V
Drain-source on-resistance	R _{DS(on)}	V _{GS} = 10V, I _D = 12A		6.8	8.5	mΩ
		V _{GS} = 4.5V, I _D = 10A		8.3	12	
Dynamic characteristics⁵⁾						
Input Capacitance	C _{iss}	V _{DS} = 35V, V _{GS} = 0V, f = 1MHz		2000		pF
Output Capacitance	C _{oss}			390		
Reverse Transfer Capacitance	C _{rss}			13		
Total Gate Charge	Q _g	V _{DS} = 30V, V _{GS} = 10V, I _D = 12A		34		nC
Gate-Source Charge	Q _{gs}			7.8		
Gate-Drain Charge	Q _{gd}			5.2		
Turn-on delay time	t _{d(on)}	V _{DD} = 30V, V _{GS} = 10V, I _D = 12A R _{GEN} = 3Ω		10		nS
Turn-on rise time	t _r			36		
Turn-off delay time	t _{d(off)}			30		
Turn-off fall time	t _f			57		
Source-Drain Diode characteristics						
Body-Diode Continuous Current	I _S				12	A
Diode Forward voltage	V _{SD}	V _{GS} = 0V, I _S = 12A			1.3	V
Reverse Recovery Charge	Q _{rr}	I _F = 12A, di/dt = 200A/us		36		nC
Reverse Recovery Time	t _{rr}			27		nS

Notes:

- 1) Repetitive rating; pulse width limited by max. junction temperature.
- 2) V_{DD}=50V, R_G=25Ω, L=0.5mH, I_{AS}=23A.
- 3) Pd is based on max. junction temperature, using ≤10s junction-ambient thermal resistance.
- 4) The value of R_{θJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A = 25°C. The Power dissipation PDSM is based on R_{θJA} t≤10s and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design.
- 5) Guaranteed by design, not subject to production testing.



Typical Characteristics

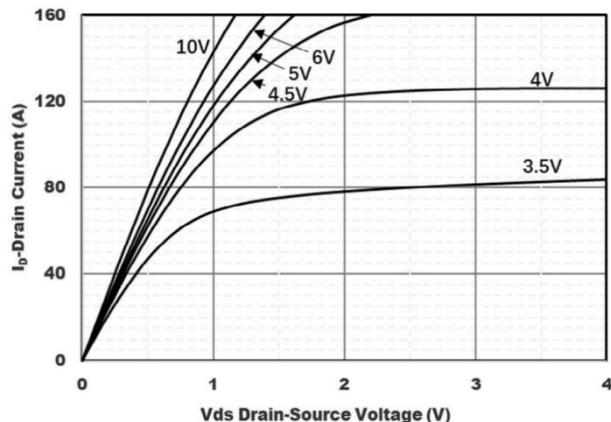


Figure1. Output Characteristics

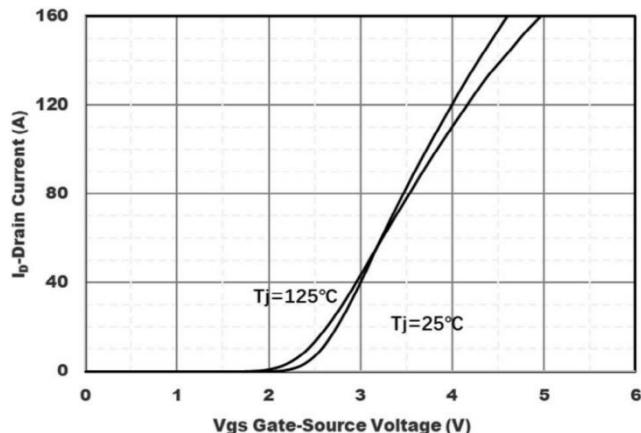


Figure2. Transfer Characteristics

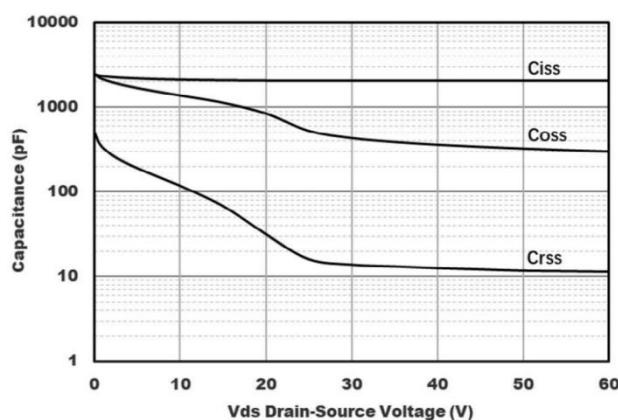


Figure3. Capacitance Characteristics

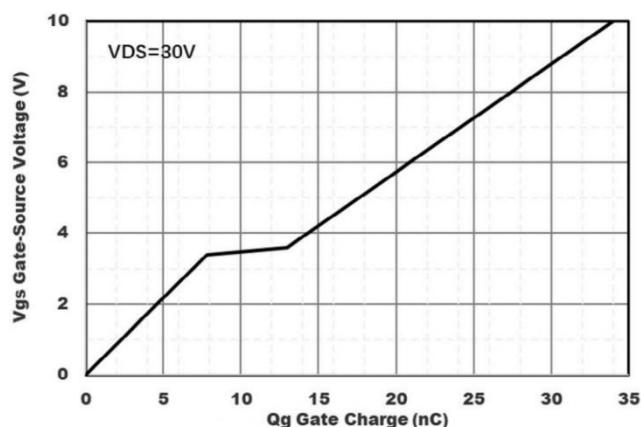


Figure4. Gate Charge

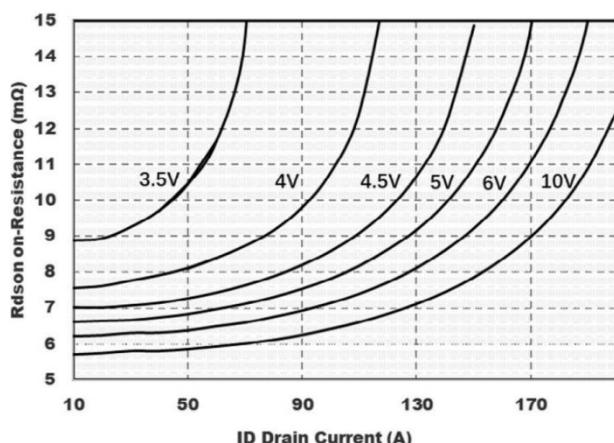


Figure5. Drain-Source on Resistance

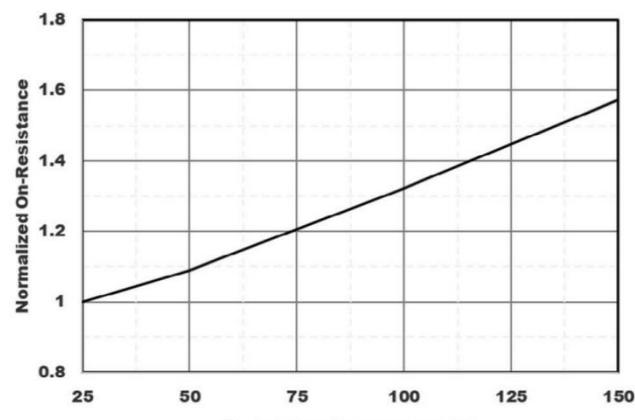


Figure6. Normalized On-Resistance

Typical Characteristics

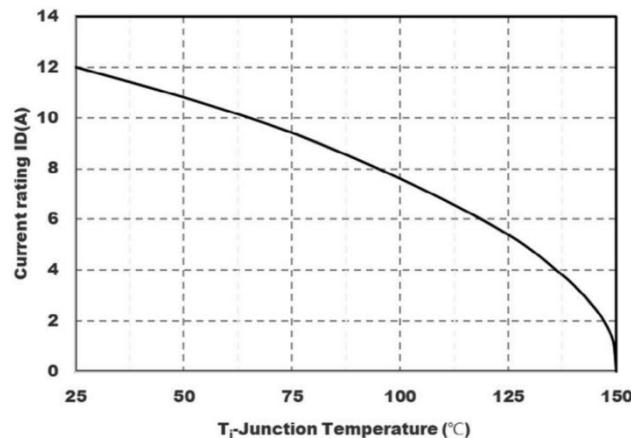


Figure7. Drain current

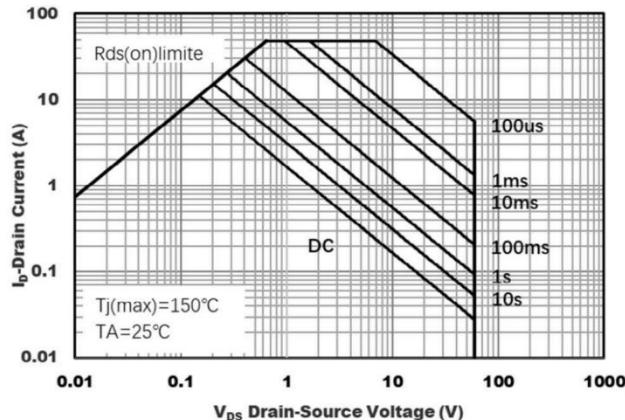


Figure8. Safe Operation Area

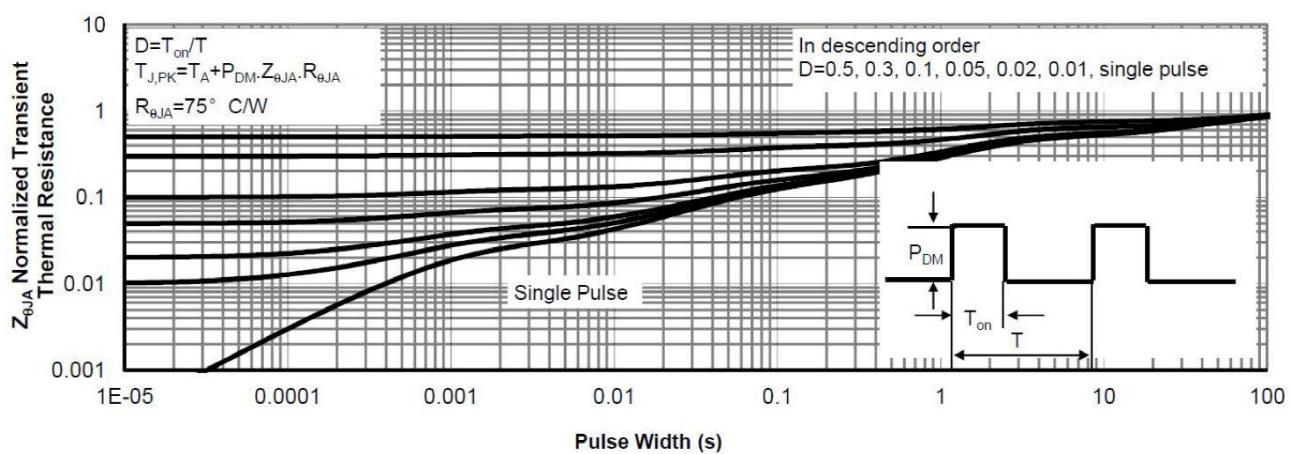
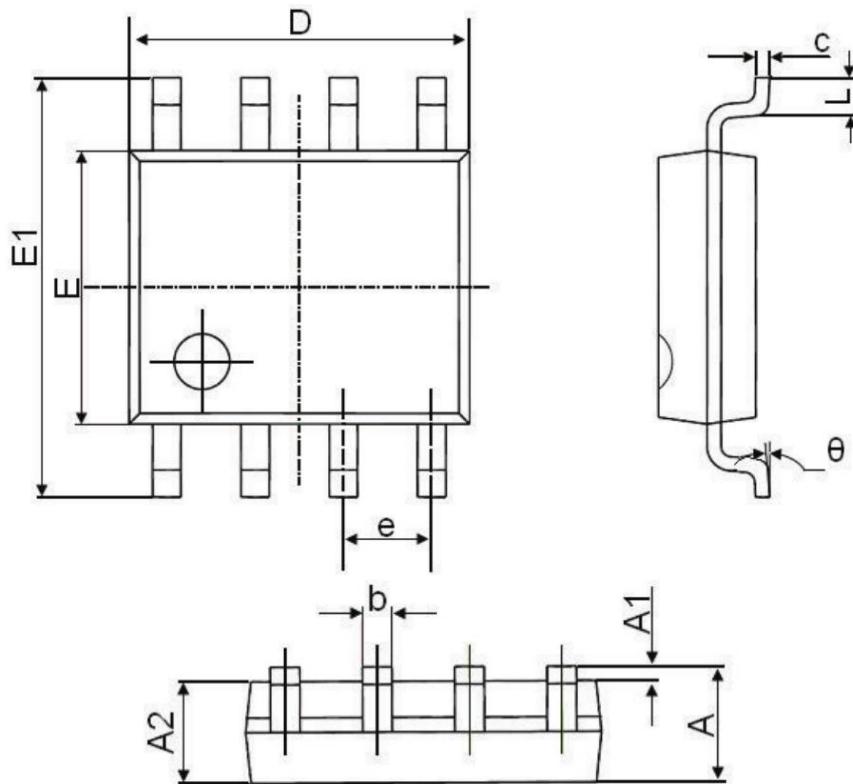


Figure9. Normalized Maximum Transient Thermal Impedance

SOP-8 Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.004	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.013	0.020
c	0.170	0.250	0.006	0.010
D	4.700	5.100	0.185	0.200
E	3.800	4.000	0.150	0.157
E1	5.800	6.200	0.228	0.244
e	1.270 BSC.		0.050 BSC.	
L	0.400	1.270	0.016	0.050
θ	0°	8°	0°	8°